## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SAVARIA ET AL. Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0027040	02-2003	Asahina et al.	429/159
*	В	US-5,510,203	04-1996	Hamada et al.	429/53
	U	US-			
	ם	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	09-259840	10-1997	Japan	(with abs., translation)	
	0					
	Ρ					
	σ					
	R					
	S					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.